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April 1st, 2010 Renesas Electronics Corporation

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MOS FIELD EFFECT TRANSISTOR μ PA2792AGR

SWITCHING N- AND P-CHANNEL POWER MOS FET

DESCRIPTION

The μ PA2792AGR is N- and P-channel MOS Field Effect Transistors designed for Motor Drive application.

FEATURES

• Low on-state resistance

N-channel R_{DS(on)1} = 12.5 m Ω MAX. (V_{GS} = 10 V, I_D = 5 A)

 $R_{DS(on)2} = 21 \text{ m}\Omega \text{ MAX.} \text{ (V}_{GS} = 4.5 \text{ V}, I_{D} = 5 \text{ A)}$

P-channel R_{DS(on)1} = 18 m Ω MAX. (V_{GS} = -10 V, I_D = -5 A)

 $R_{DS(on)2} = 26 \text{ m}\Omega \text{ MAX.}$ (Vgs = -4.5 V, ID = -5 A)

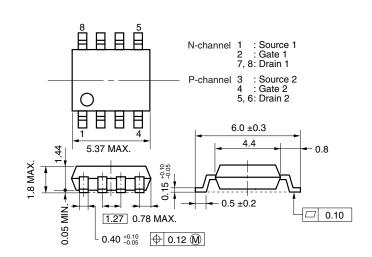
· Low input capacitance

N-channel C_{iss} = 2200 pF TYP.

P-channel C_{iss} = 2200 pF TYP.

- Built-in gate protection diode
- Small and surface mount package (Power SOP8)

PACKAGE DRAWING (Unit: mm)

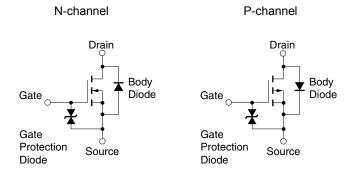


ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE		
μPA2792AGR-E1-AT Note					
μPA2792AGR-E2-AT Note	Pure Sn	Tape 2500 p/reel	Power SOP8		

Note Pb-free (This product does not contain Pb in external electrode and other parts.)

EQUIVALENT CIRCUITS



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD.

When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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ABSOLUTE MAXIMUM RATINGS (TA = 25°C. All terminals are connected.)

PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Drain to Source Voltage (V _{GS} = 0 V)	V _{DSS}	30	-30	V
Gate to Source Voltage (VDS = 0 V)	V _{GSS}	±20	∓20	V
Drain Current (DC)	I _{D(DC)}	±10	∓10	А
Drain Current (pulse) Note1	ID(pulse)	±40	∓40	А
Total Power Dissipation (1 unit) Note2	P _{T1}	1.7		W
Total Power Dissipation (2 units) Note2	P _{T2}	2.0		W
Channel Temperature	Tch	150		°C
Storage Temperature	T _{stg}	−55 to +150		°C
Single Avalanche Current Note3	las	10	-10	А
Single Avalanche Energy Note3	Eas	10		mJ

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

- 2. Mounted on ceramic substrate of 2000 mm² x 1.6 mm
- 3. Starting Tch = 25°C, VdD = 15 V, Rg = 25 Ω , L = 100 μ H, Vgs = 20 \rightarrow 0 V



ELECTRICAL CHARACTERISTICS (TA = 25°C. All terminals are connected.)

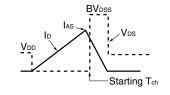
N-channel

SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
IDSS	V _{DS} = 30 V, V _{GS} = 0 V			10	μΑ
Igss	V _{GS} = ±20 V, V _{DS} = 0 V			±10	μΑ
V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5	2.0	2.5	V
y _{fs}	V _{DS} = 10 V, I _D = 5 A	5	10		S
RDS(on)1	V _{GS} = 10 V, I _D = 5 A		10	12.5	mΩ
R _{DS(on)2}	V _{GS} = 4.5 V, I _D = 5 A		14.5	21	mΩ
Ciss	V _{DS} = 10 V,		2200		pF
Coss	V _{GS} = 0 V,		380		pF
Crss	f = 1 MHz		250		pF
t _{d(on)}	V _{DD} = 15 V, I _D = 5 A,		9.6		ns
tr	V _{GS} = 10 V,		21		ns
t _{d(off)}	R _G = 0 Ω		52		ns
tr			12		ns
Q _G	ID = 10 A,		42		nC
Qgs	V _{DD} = 24 V,		6.2		nC
Q _{GD}	V _{GS} = 10 V		13		nC
V _{F(S-D)}	I _F = 10 A, V _{GS} = 0 V		0.83	1.5	V
trr	I _F = 10 A, V _{GS} = 0 V,		30		ns
Qrr	di/dt = 100 A/μs		22		nC
	IDSS	IDSS	IDSS	$\begin{array}{llllllllllllllllllllllllllllllllllll$	$\begin{array}{llllllllllllllllllllllllllllllllllll$

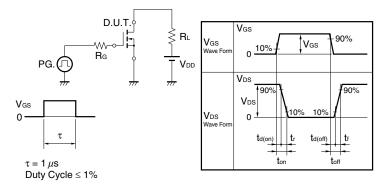
Note Pulsed

TEST CIRCUIT 1 AVALANCHE CAPABILITY

$\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \ \Omega \\ \text{V} \\ \text{V} \\ \text{S} = 20 \rightarrow 0 \ \text{V} \end{array}$



TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE

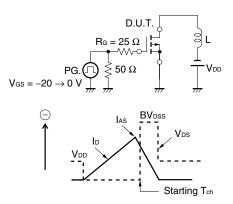


P-channel

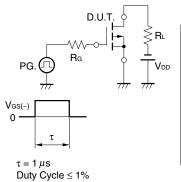
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	Ipss	V _{DS} = -30 V, V _{GS} = 0 V			-10	μΑ
Gate Leakage Current	Igss	V _{GS} = ∓20 V, V _{DS} = 0 V			∓10	μΑ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = -10 V, I _D = -1 mA	-1.0	-1.7	-2.5	V
Forward Transfer Admittance Note	y fs	V _{DS} = -10 V, I _D = -5 A	6	12.9		S
Drain to Source On-state Resistance Note	RDS(on)1	V _{GS} = -10 V, I _D = -5 A		14	18	mΩ
	RDS(on)2	V _{GS} = -4.5 V, I _D = -5 A		17.5	26	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V,		2200		pF
Output Capacitance	Coss	V _{GS} = 0 V,		510		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		410		pF
Turn-on Delay Time	td(on)	V _{DD} = -15 V, I _D = -5 A,		12		ns
Rise Time	tr	V _{GS} = -10 V,		19		ns
Turn-off Delay Time	td(off)	$R_G = 0 \Omega$		130		ns
Fall Time	tr			36		ns
Total Gate Charge	Q _G	I _D = -10 A,		47		nC
Gate to Source Charge	Qgs	V _{DD} = -24 V,		5.2		nC
Gate to Drain Charge	Q _{GD}	V _{GS} = -10 V		15		nC
Body Diode Forward Voltage Note	VF(S-D)	I _F = 10 A, V _{GS} = 0 V		0.87	1.5	V
Reverse Recovery Time	trr	I _F = -10 A, V _{GS} = 0 V,		57		ns
Reverse Recovery Charge	Qrr	di/dt = -50 A/μs		41		nC

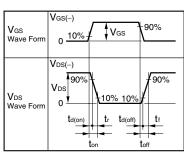
Note Pulsed

TEST CIRCUIT 1 AVALANCHE CAPABILITY



TEST CIRCUIT 2 SWITCHING TIME



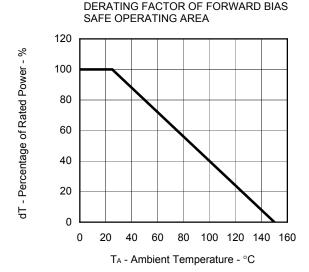


TEST CIRCUIT 3 GATE CHARGE

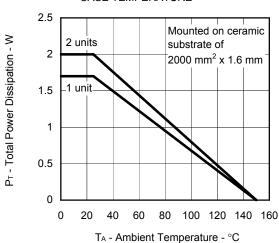
$$\begin{array}{c|c} D.U.T. \\ \hline \\ I_G = -2 \text{ mA} \\ \hline \\ PG. \\ \hline \\ \end{array}$$

TYPICAL CHARACTERISTICS (TA = 25°C)

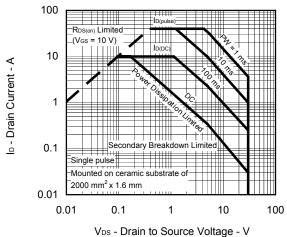
(1) N-channel



TOTAL POWER DISSIPATION vs. CASE TEMPERATURE

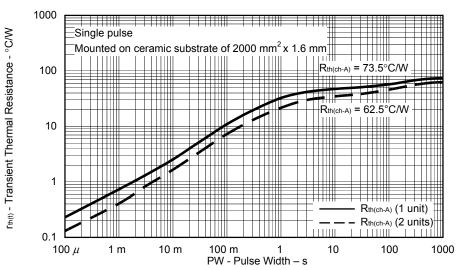


FORWARD BIAS SAFE OPERATING AREA



o e

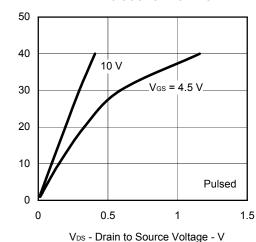
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



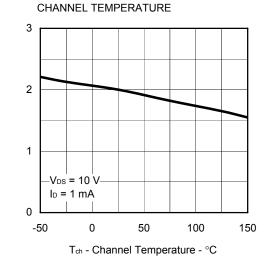
Ib - Drain Current - A

VGS(off) - Gate to Source Cut-off Voltage - V

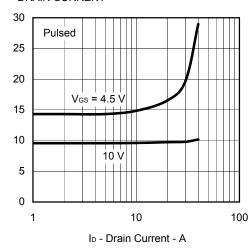
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



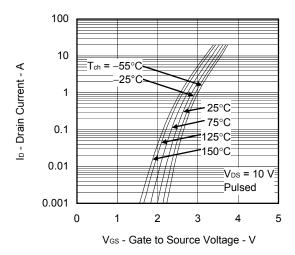
GATE TO SOURCE CUT-OFF VOLTAGE vs.



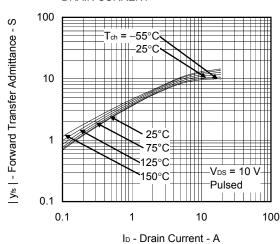
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



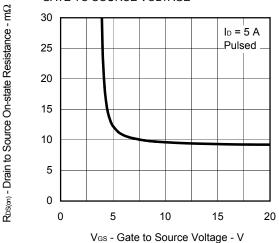
FORWARD TRANSFER CHARACTERISTICS



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

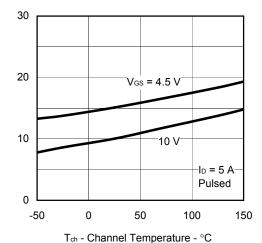


R_{DS(α1)} - Drain to Source On-state Resistance - mΩ

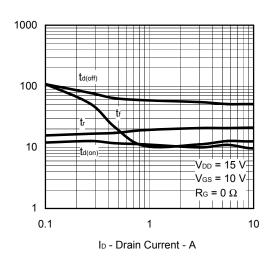
 $\mathsf{Ro}_{\mathsf{S}(m)}$ - Drain to Source On-state Resistance - $m\Omega$

ta(on), tr, ta(off), tr - Switching Time - ns

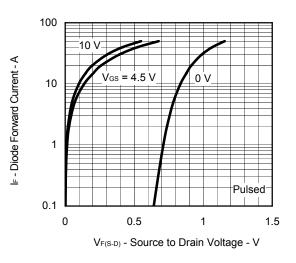
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



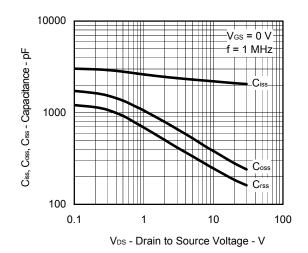
SWITCHING CHARACTERISTICS



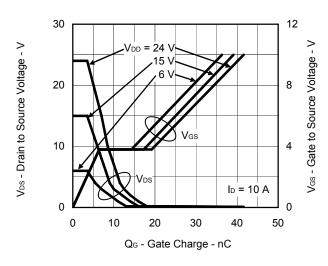
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



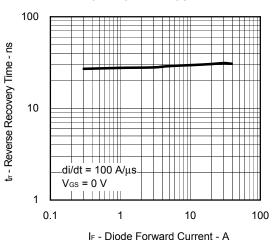
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



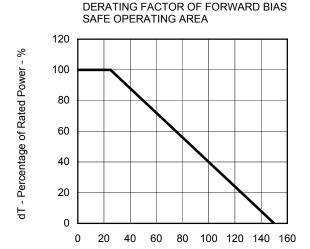
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



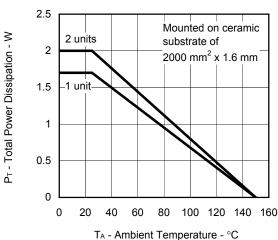
REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT



(2) P-channel

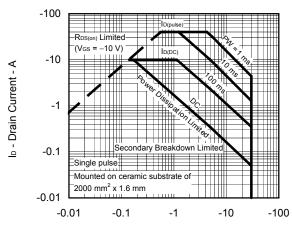


TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



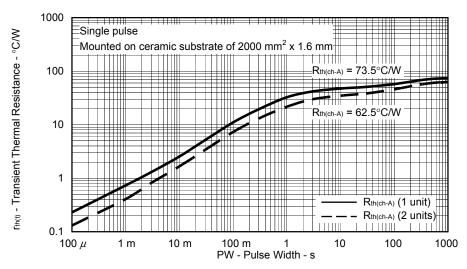
FORWARD BIAS SAFE OPERATING AREA

TA - Ambient Temperature - °C



 $V_{\text{\scriptsize DS}}$ - Drain to Source Voltage - V

TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

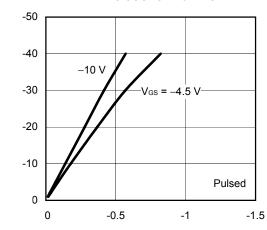


lo - Drain Current - A

VGS(off) - Gate to Source Cut-off Voltage - V

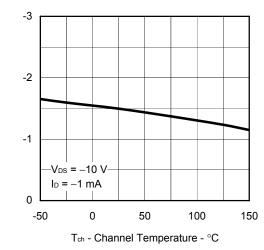
R_{DS(α1)} - Drain to Source On-state Resistance - mΩ

DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

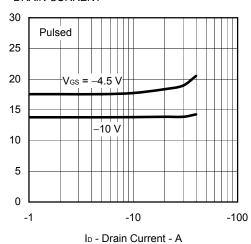


GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

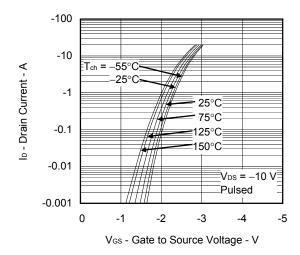
VDS - Drain to Source Voltage - V



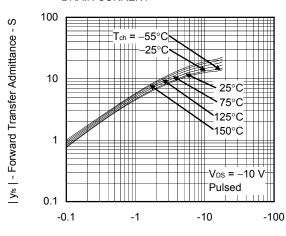
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



FORWARD TRANSFER CHARACTERISTICS

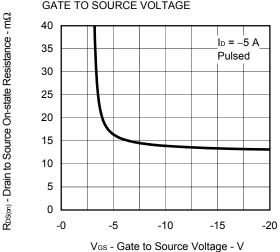


FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

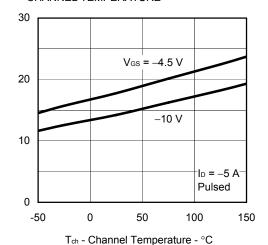
ID - Drain Current - A



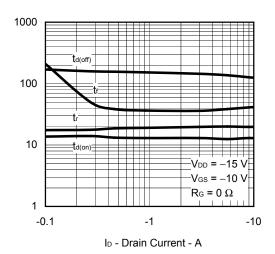
 $\mathsf{Ros}_{(m)}$ - Drain to Source On-state Resistance - $m\Omega$

td(on), tr, td(off), tr - Switching Time - ns

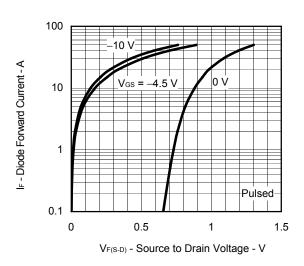
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



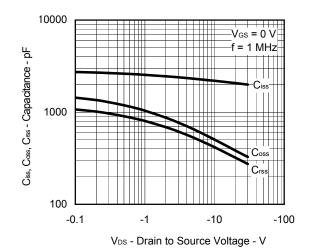
SWITCHING CHARACTERISTICS



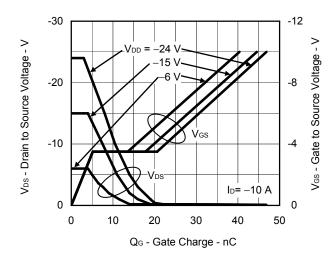
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



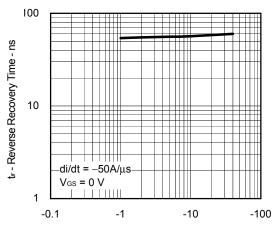
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT

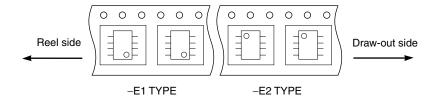


IF - Diode Forward Current - A

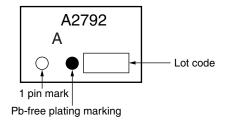


TAPE INFORMATION

There are two types (-E1, -E2) of taping depending on the direction of the device.



MARKING INFORMATION



RECOMMENDED SOLDERING CONDITIONS

The μ PA2792AGR should be soldered and mounted under the following recommended conditions.

For soldering methods and conditions other than those recommended below, please contact an NEC Electronics sales representative.

For technical information, see the following website.

Semiconductor Device Mount Manual (http://www.necel.com/pkg/en/mount/index.html)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Maximum temperature (Package's surface temperature): 260°C or below	IR60-00-3
	Time at maximum temperature: 10 seconds or less	
	Time of temperature higher than 220°C: 60 seconds or less	
	Preheating time at 160 to 180°C: 60 to 120 seconds	
	Maximum number of reflow processes: 3 times	
	Maximum chlorine content of rosin flux (percentage mass): 0.2% or less	
Partial heating	Maximum temperature (Pin temperature): 350°C or below	P350
	Time (per side of the device): 3 seconds or less	
	Maximum chlorine content of rosin flux: 0.2% (wt.) or less	

Caution Do not use different soldering methods together (except for partial heating).

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- While NEC Electronics endeavors to enhance the quality and safety of NEC Electronics products, customers agree and acknowledge that the possibility of defects thereof cannot be eliminated entirely. In addition, NEC Electronics products are not taken measures to prevent radioactive rays in the product design. When customers use NEC Electronics products with their products, customers shall, on their own responsibility, incorporate sufficient safety measures such as redundancy, fire-containment and anti-failure features to their products in order to avoid risks of the damages to property (including public or social property) or injury (including death) to persons, as the result of defects of NEC Electronics products.
- NEC Electronics products are classified into the following three quality grades: "Standard", "Special" and "Specific".

The "Specific" quality grade applies only to NEC Electronics products developed based on a customer-designated "quality assurance program" for a specific application. The recommended applications of an NEC Electronics product depend on its quality grade, as indicated below. Customers must check the quality grade of each NEC Electronics product before using it in a particular application.

- "Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots.
- "Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support).
- "Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.

The quality grade of NEC Electronics products is "Standard" unless otherwise expressly specified in NEC Electronics data sheets or data books, etc. If customers wish to use NEC Electronics products in applications not intended by NEC Electronics, they must contact an NEC Electronics sales representative in advance to determine NEC Electronics' willingness to support a given application.

(Note)

- (1) "NEC Electronics" as used in this statement means NEC Electronics Corporation and also includes its majority-owned subsidiaries.
- (2) "NEC Electronics products" means any product developed or manufactured by or for NEC Electronics (as defined above).